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(71) Applicant (for all designated States except US): **MICRON TECHNOLOGY, INC.** [US/US]; 8000 S. Federal Way, Boise, ID 83707-0006 (US).

(72) Inventor; and

(75) Inventor/Applicant (for US only): **YAN, Hai** [CN/US]; 7136 Elsa Court, Fontana, CA 92336 (US).

(74) Agent: **D'AMICO, Thomas, J.**; DICKSTEIN SHAPIRO MORIN & OSHINSKY LLP, 2101 L Street NW, Washington, DC 20037-1526 (US).

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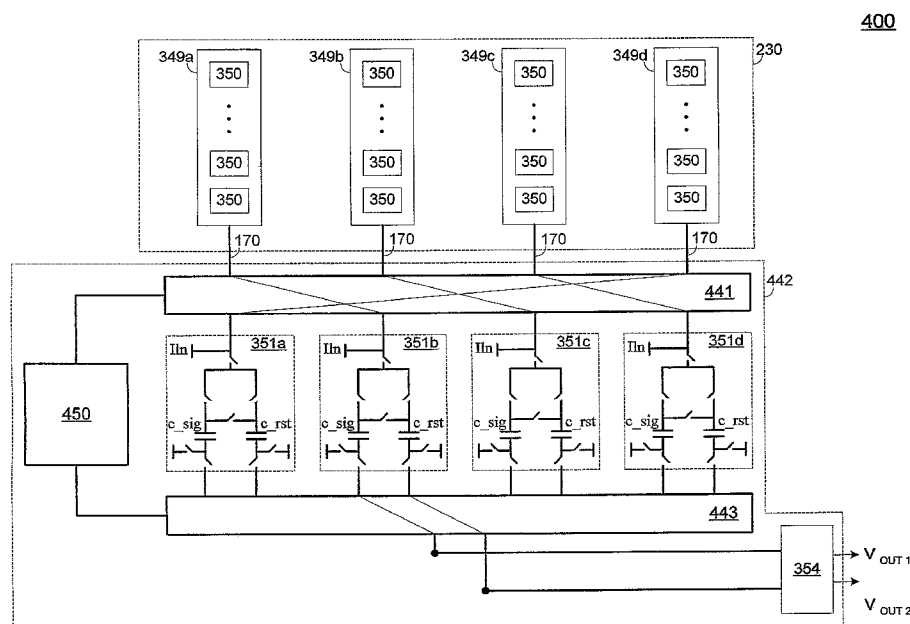
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(54) Title: METHOD AND APPARATUS FOR REDUCTION OF FIXED PATTERN NOISE IN A SOLID STATE IMAGING SENSOR



(57) Abstract: An imager having a switching circuit that couples pixel columns to different sample and hold circuits to reduce the noticeability of column-wise fixed pattern noise, A controller randomly couples a pixel column to a sample and hold circuit, therefore fixed pattern noise emanating from a particular sample and hold circuit is not always associated with a single pixel column. Therefore the visual perception of fixed pattern noise associated with a particular sample and hold circuit is reduced.